## Notice of References Cited Application/Control No. 10/529,412 Examiner Elizabeth Burkhart Applicant(s)/Patent Under Reexamination HECHT ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
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	Η	US-			
	I	US-			
	J	US-			
	K	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-230034	08-1999	Japan	Kawamura et al	
	0					
	Р					
	Q					
	R					
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## NON-PATENT DOCUMENTS

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